

Notice of References Cited	Application/Control No. 10/652,486	Applicant(s)/Patent Under Reexamination SANO ET AL.	
	Examiner Alexander Eisen	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,958,105	09-1990	Young et al.	315/169.3
*	B	US-5,313,414	05-1994	Yang et al.	708/625
*	C	US-7,034,468	04-2006	Kim et al.	315/169.4
*	D	US-6,922,180	07-2005	Iwami et al.	345/60
*	E	US-2001/0029102	10-2001	Okamura et al.	438/689
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	N	JP 11344952 A	12-1999	Japan	TAKAYAMA et al.	G09G 3/28
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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